ON Semiconductor

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QFET®

ON Semiconductor®

FQP3N50C/FQPF3N50C 500V N-Channel MOSFET

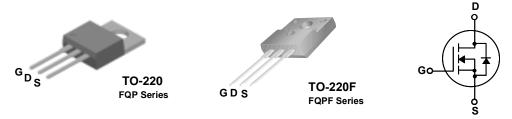
Features

- 3 A, 500 V, $R_{DS(on)}$ = 2.5 Ω @ V_{GS} = 10 V
- Low gate charge (typical 10 nC)
- · Low Crss (typical 8.5 pF)
- · Fast switching
- 100 % avalanche tested
- · Improved dv/dt capability

Description

These N-Channel enhancement mode power field effect transistors are produced using ON Semiconductor's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction, electronic lamp ballasts based on half bridge topology.



Absolute Maximum Ratings

Symbol	Parameter		FQP3N50C	FQPF3N50C	Units	
V _{DSS}	Drain-Source V	in-Source Voltage			V	
I _D	Drain Current - Continuous (T _C = 25°C)		3 3*		Α	
		- Continuous (T _C = 100°C))	1.8	1.8 *	Α
I _{DM}	Drain Current	- Pulsed	(Note 1)	12	12 *	Α
V _{GSS}	Gate-Source Voltage		± 30		V	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		(Note 2)	200		mJ
I _{AR}	Avalanche Current		(Note 1)	3		Α
E _{AR}	Repetitive Avalanche Energy		(Note 1)	6.2		mJ
dv/dt	Peak Diode Recovery dv/dt (No		(Note 3)	4.5		V/ns
P _D	Power Dissipation (T _C = 25°C)			62	25	W
	- Derate above 25°C			0.5	0.2	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150		°C	
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300		°C	

^{*} Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FQP3N50C	FQPF3N50C	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	2.0	4.9	°C/W
$R_{\theta JS}$	Thermal Resistance, Case-to-Sink Typ.	0.5		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	°C/W

Publication Order Number: FQP3N50C/D

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FQP3N50C	FQP3N50C	TO-220			50
FQPF3N50C	FQPF3N50C	TO-220F			50

Electrical Characteristics T_C = 25°C unless otherwise noted

Symbol	Parameter Test Conditions		Min.	Тур.	Max.	Units
Off Characte	ristics					
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	500			V
$\Delta BV_{DSS}/$ ΔT_J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.7		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 500 V, V _{GS} = 0 V			1	μΑ
		V _{DS} = 400 V, T _C = 125°C			10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
On Characte	ristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 1.5 A		2.1	2.5	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 1.5 A (Note 4)		1.5		S
Dynamic Ch	aracteristics					T
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$		280	365	pF
C _{oss}	Output Capacitance	f = 1.0 MHz		50	65	pF
C _{rss}	Reverse Transfer Capacitance			8.5	11	pF
Switching Cl	haracteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 250 V, I _D = 3 A,		10	30	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$		25	60	ns
t _{d(off)}	Turn-Off Delay Time			35	80	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		25	60	ns
Qg	Total Gate Charge	V _{DS} = 400 V, I _D = 3 A,		10	13	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V		1.5		nC
Q_{gd}	Gate-Drain Charge	(Note 4, 5)		5.5		nC
Drain-Source	e Diode Characteristics and Maximum R	atings				
I _S	Maximum Continuous Drain-Source Diode Forward Current				3	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				12	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 3 A			1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 3 A,		170		ns
Q _{rr}	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s \qquad (Note 4)$		0.7		μС

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 40mH, I_{AS} = 3A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25°C
- 3. $I_{SD} \le 3A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting T_J = 25°C
- 4. Pulse Test : Pulse width $\leq 300 \mu s, \, \text{Duty cycle} \leq 2\%$
- 5. Essentially independent of operating temperature

Typical Performance Characteristics

Figure 1. On-Region Characteristics

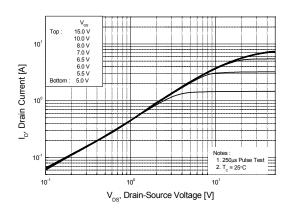


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

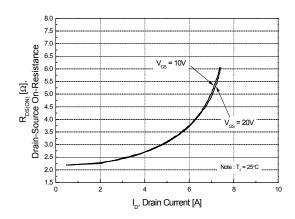


Figure 5. Capacitance Characteristics

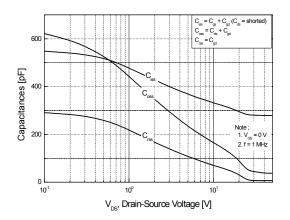


Figure 2. Transfer Characteristics

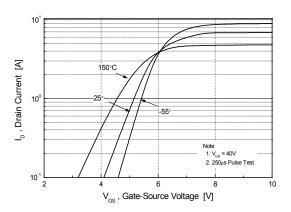


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

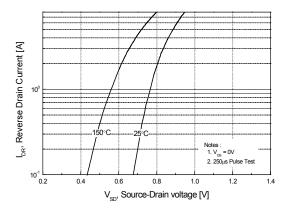
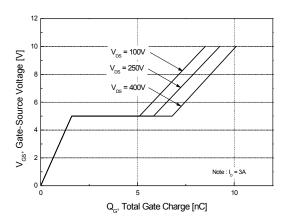


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

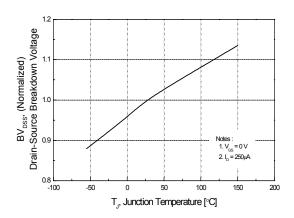


Figure 9-1. Maximum Safe Operating Area of FQP3N50C

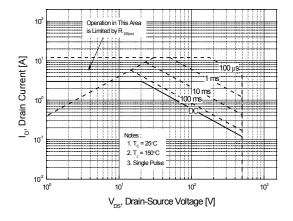


Figure 10. Maximum Drain Current

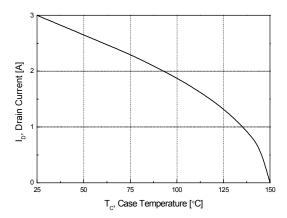


Figure 8. On-Resistance Variation vs. Temperature

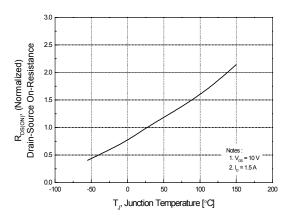
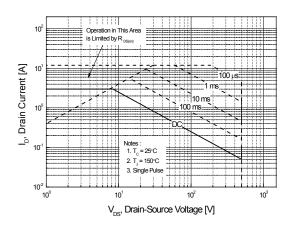


Figure 9-2. Maximum Safe Operating Area of FQPF3N50C



Typical Performance Characteristics (Continued)

Figure 11-1. ransient Thermal Response Curve of FQP3N50C

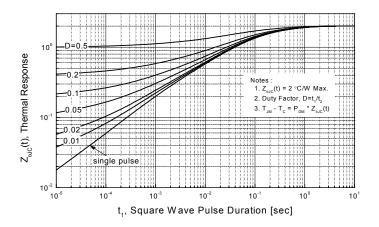
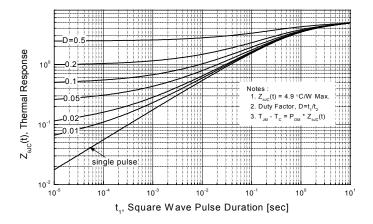
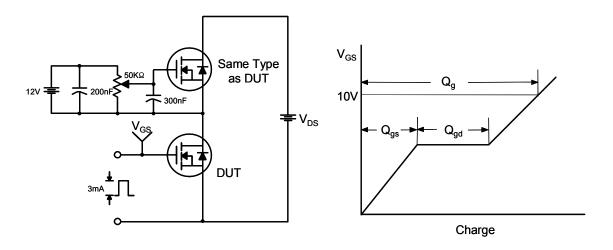


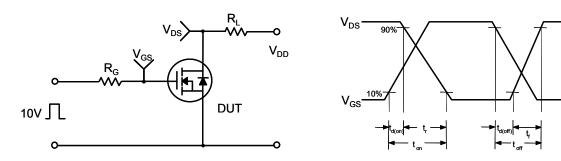
Figure 11-2. ransient Thermal Response Curve of FQPF3N50C



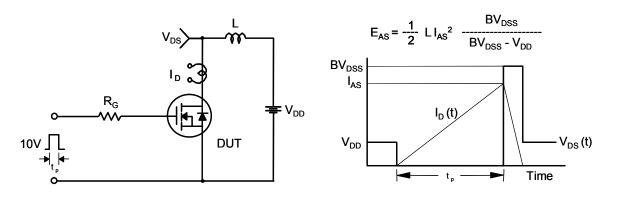
Gate Charge Test Circuit & Waveform



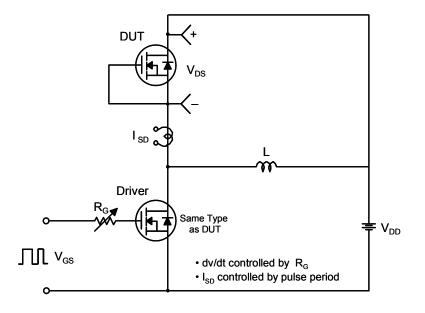
Resistive Switching Test Circuit & Waveforms

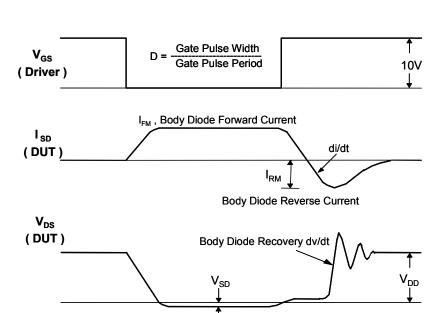


Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms

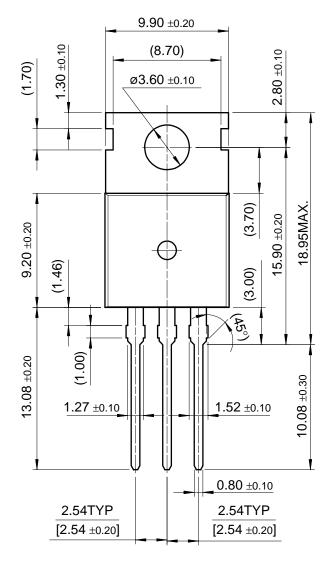


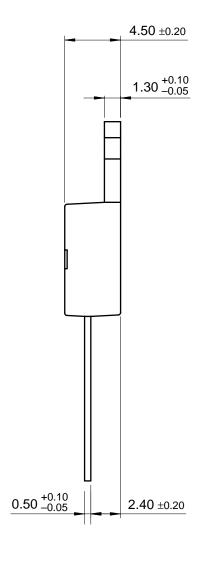


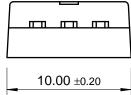
Body Diode Forward Voltage Drop

Mechanical Dimensions

TO-220

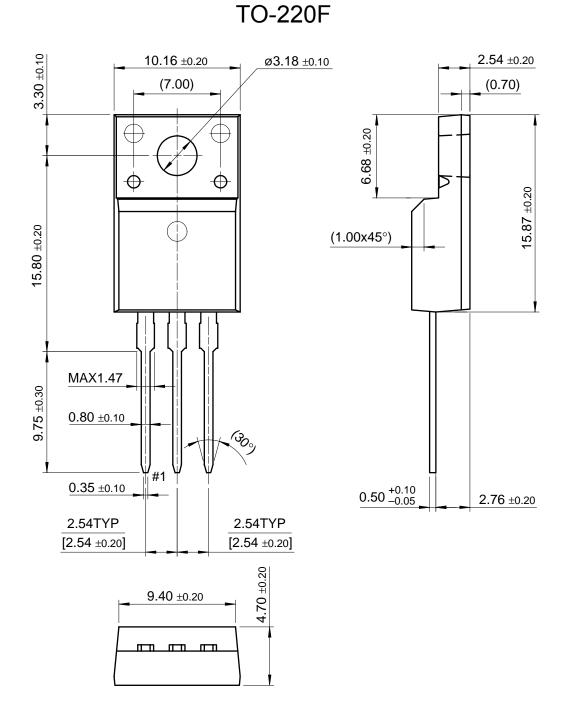






Dimensions in Millimeters

Mechanical Dimensions (Continued)



Dimensions in Millimeters

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